

TA Technology (Shanghai) Co., Ltd. Test Report

Report No.: RZA2009-0995

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ANNEX D: Probe Calibration Certificate

**Calibration Laboratory of
Schmid & Partner
Engineering AG**
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 108**

Client **TA Shanghai (Auden)**

Certificate No: **ET3-1737_Nov08**

CALIBRATION CERTIFICATE

Object	ET3DV6 - SN:1737
Calibration procedure(s)	QA CAL-01.v6, QA CAL-12.v5 and QA CAL-23.v3 Calibration procedure for dosimetric E-field probes
Calibration date:	November 25, 2008
Condition of the calibrated item	In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	1-Apr-08 (No. 217-00788)	Apr-09
Power sensor E4412A	MY41495277	1-Apr-08 (No. 217-00788)	Apr-09
Power sensor E4412A	MY41498087	1-Apr-08 (No. 217-00788)	Apr-09
Reference 3 dB Attenuator	SN: S5054 (3c)	1-Jul-08 (No. 217-00865)	Jul-09
Reference 20 dB Attenuator	SN: S5086 (20b)	31-Mar-08 (No. 217-00787)	Apr-09
Reference 30 dB Attenuator	SN: S5129 (30b)	1-Jul-08 (No. 217-00866)	Jul-09
Reference Probe ES3DV2	SN: 3013	2-Jan-08 (No. ES3-3013_Jan08)	Jan-09
DAE4	SN: 660	9-Sep-08 (No. DAE4-660_Sep08)	Sep-09

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642UD1700	4-Aug-99 (in house check Oct-07)	In house check: Oct-09
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-08)	In house check: Oct-09

Calibrated by:	Name	Function	Signature
	Katja Pokovic	Technical Manager	
Approved by:	Niels Kuster	Quality Manager	

Issued: November 25, 2008

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Calibration Laboratory of
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Accreditation No.: SCS 108

Glossary:

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}:** Assessed for E-field polarization $\vartheta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not effect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)_{x,y,z} = NORM_{x,y,z} * frequency_response** (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP_{x,y,z}:** DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- ConvF and Boundary Effect Parameters:** Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy):** in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset:** The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

ET3DV6 SN:1737

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Probe ET3DV6

SN:1737

Manufactured:	September 27, 2002
Last calibrated:	February 19, 2007
Repaired:	November 18, 2008
Recalibrated:	November 25, 2008

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

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November 25, 2008

DASY - Parameters of Probe: ET3DV6 SN:1737

Sensitivity in Free Space^A

Diode Compression^B

NormX	1.42 ± 10.1%	μV/(V/m) ²	DCP X	93 mV
NormY	1.68 ± 10.1%	μV/(V/m) ²	DCP Y	94 mV
NormZ	1.63 ± 10.1%	μV/(V/m) ²	DCP Z	85 mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8.

Boundary Effect

TSL 900 MHz Typical SAR gradient: 5 % per mm

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR _{be} [%]	Without Correction Algorithm	10.7	6.9
SAR _{be} [%]	With Correction Algorithm	0.3	0.4

TSL 1750 MHz Typical SAR gradient: 10 % per mm

Sensor Center to Phantom Surface Distance		3.7 mm	4.7 mm
SAR _{be} [%]	Without Correction Algorithm	12.5	8.4
SAR _{be} [%]	With Correction Algorithm	0.8	0.5

Sensor Offset

Probe Tip to Sensor Center 2.7 mm

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of NormX,Y,Z do not affect the E²-field uncertainty inside TSL (see Page 8).

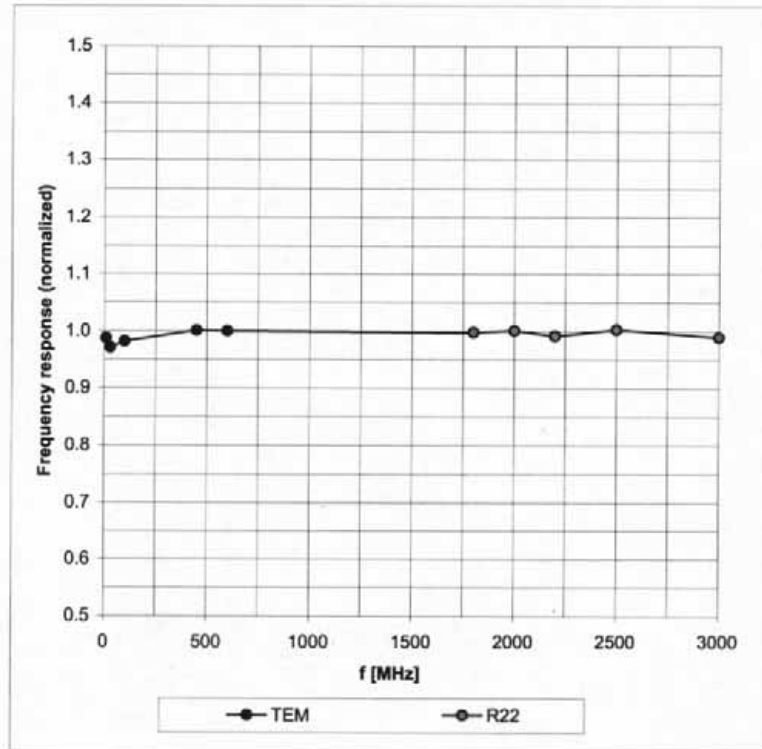
^B Numerical linearization parameter: uncertainty not required.

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Frequency Response of E-Field

(TEM-Cell: ifi110 EXX, Waveguide: R22)

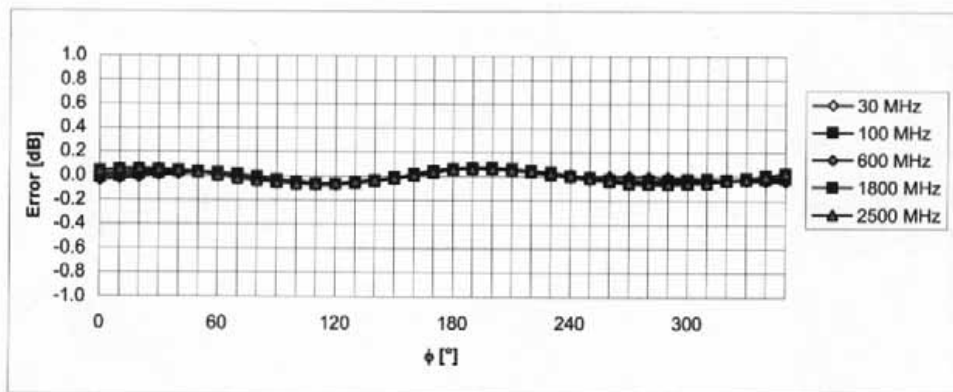
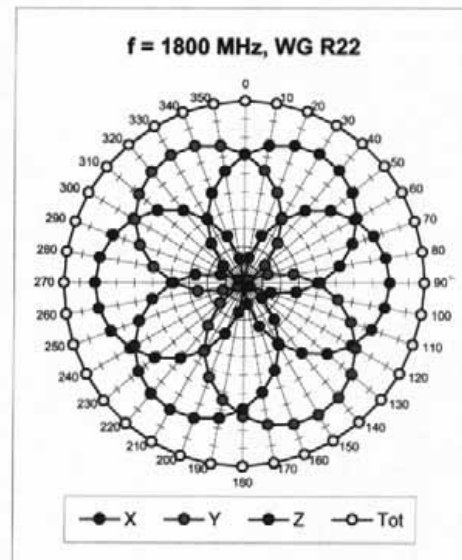
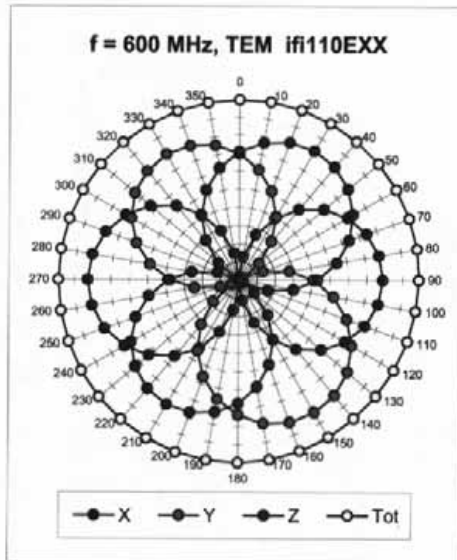


Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

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Receiving Pattern (ϕ), $\theta = 0^\circ$

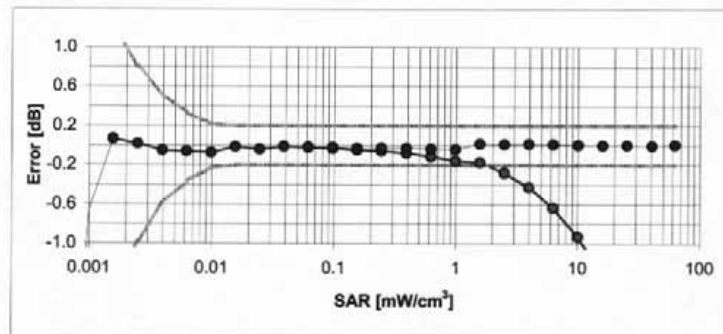
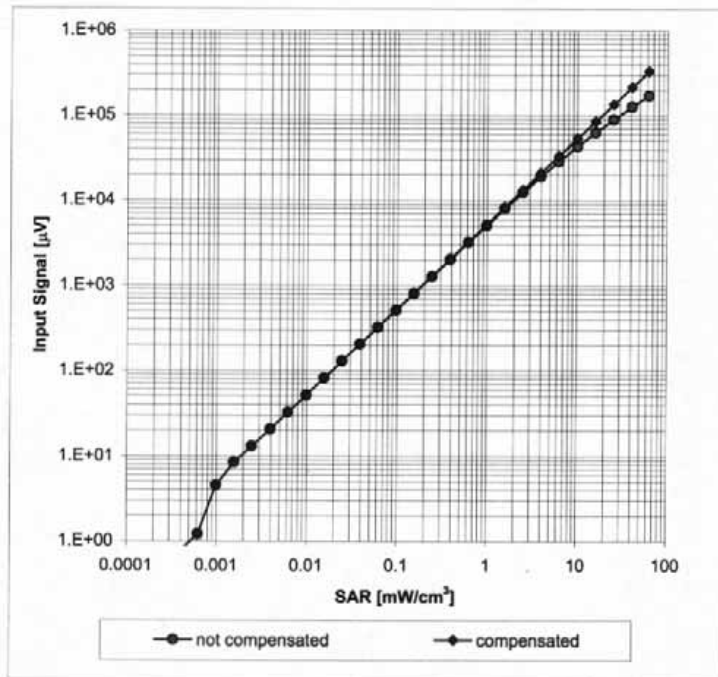


Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ (k=2)

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Dynamic Range $f(SAR_{head})$
(Waveguide R22, $f = 1800$ MHz)

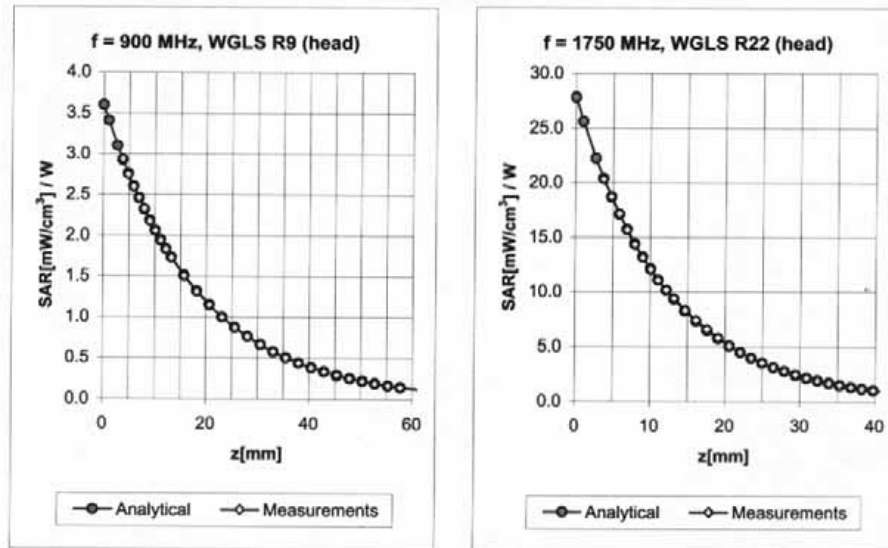


Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

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Conversion Factor Assessment



f [MHz]	Validity [MHz] ^c	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
450	± 50 / ± 100	Head	43.5 ± 5%	0.87 ± 5%	0.36	1.84	7.20 ± 13.3% (k=2)
835	± 50 / ± 100	Head	41.5 ± 5%	0.90 ± 5%	0.25	3.53	6.33 ± 11.0% (k=2)
900	± 50 / ± 100	Head	41.5 ± 5%	0.97 ± 5%	0.27	3.53	6.14 ± 11.0% (k=2)
1750	± 50 / ± 100	Head	40.1 ± 5%	1.37 ± 5%	0.56	2.77	5.35 ± 11.0% (k=2)
1950	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.57	2.72	4.89 ± 11.0% (k=2)
2450	± 50 / ± 100	Head	39.2 ± 5%	1.80 ± 5%	0.51	1.60	4.39 ± 11.0% (k=2)
450	± 50 / ± 100	Body	56.7 ± 5%	0.94 ± 5%	0.27	1.80	7.52 ± 13.3% (k=2)
835	± 50 / ± 100	Body	55.2 ± 5%	0.97 ± 5%	0.36	2.75	6.14 ± 11.0% (k=2)
900	± 50 / ± 100	Body	55.0 ± 5%	1.05 ± 5%	0.43	2.51	5.98 ± 11.0% (k=2)
1750	± 50 / ± 100	Body	53.4 ± 5%	1.49 ± 5%	0.99	1.74	4.84 ± 11.0% (k=2)
1950	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.99	1.50	4.60 ± 11.0% (k=2)
2450	± 50 / ± 100	Body	52.7 ± 5%	1.95 ± 5%	0.98	1.42	3.91 ± 11.0% (k=2)

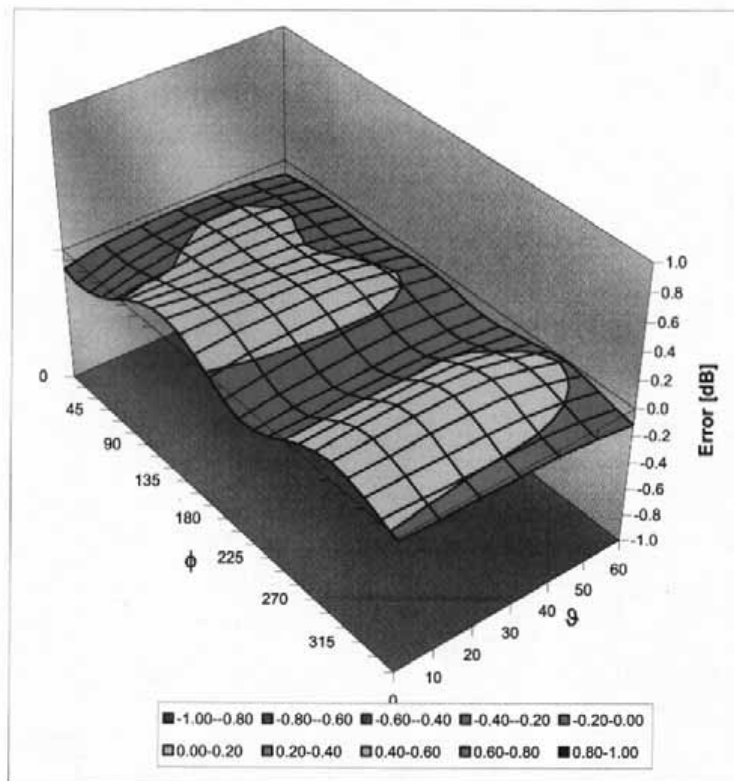
^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

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Deviation from Isotropy in HSL

Error (ϕ , θ), $f = 900$ MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ ($k=2$)

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ANNEX E: D835V2 Dipole Calibration Certificate

信息产业部通信计量中心
Telecommunication Metrology Center of MII



Client

TA

Certificate No: D835V2-4d020_Jul09

检测
CNAS L0442

CALIBRATION CERTIFICATE

Object	D835V2 - SN: 4d020
Calibration Procedure(s)	TMC-XZ-01-027 Calibration procedure for dipole validation kits
Calibration date:	July 15, 2009
Condition of the calibrated item	In Tolerance

This calibration Certificate documents the traceability to national standards, which realize the physical units of measurements(SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature(22±3)°C and humidity<70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
Power Meter NRVD	101253	19-Jun-09 (TMC, No.JZ09-248)	Jun-10
Power sensor NRV-Z5	100333	19-Jun-09 (TMC, No. JZ09-248)	Jun-10
Reference Probe ES3DV3	SN 3149	08-Dec-08(SPEAG, No.ES3-3149_Dec08)	Dec-09
DAE4	SN 771	21-Nov-08(SPEAG, No.DAE4-771_Nov08)	Nov-09
RF generator E4438C	MY45092879	18-Jun-09(TMC, No.JZ09-302)	Jun-10
Network Analyzer 8753E	US38433212	03-Aug-08(TMC, No.JZ08-056)	Aug-09

	Name	Function	Signature
Calibrated by:	Lin Hao	SAR Test Engineer	
Reviewed by:	Qi Dianyuan	SAR Project Leader	
Approved by:	Lu Bingsong	Deputy Director of the laboratory	

Issued: July 15, 2009

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Certificate No: D835V2-4d020_Jul09

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Glossary:

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM _{x,y,z}
N/A	not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) For hand-held devices used in close proximity to the ear (frequency range of 300MHz to 3GHz)", February 2005
- c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

- d) DASY System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V5.0
Extrapolation	Advanced Extrapolation	
Phantom	2mm Oval Phantom ELI4	
Distance Dipole Center - TSL	15 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	835 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	41.5	0.90 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	41.2 ± 6 %	0.91mho/m ± 6 %
Head TSL temperature during test	(21.7 ± 0.2) °C	----	----

SAR result with Head TSL

SAR averaged over 1 cm³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	2.40 mW / g
SAR normalized	normalized to 1W	9.60 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	9.2 mW /g ± 17.0 % (k=2)

SAR averaged over 10 cm³ (10 g) of Head TSL	Condition	
SAR measured	250 mW input power	1.55 mW / g
SAR normalized	normalized to 1W	6.20 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	6.07 mW /g ± 16.5 % (k=2)

¹ Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

TA Technology (Shanghai) Co., Ltd.

Test Report

Body TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	55.2	0.97 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	54.6 ± 6%	0.99mho/m ± 6 %
Body TSL temperature during test	(21.9 ± 0.2) °C	----	----

SAR result with Body TSL

SAR averaged over 1 cm^3 (1 g) of Body TSL	Condition	
SAR measured	250 mW input power	2.41 mW / g
SAR normalized	normalized to 1W	9.64 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	9.28 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm^3 (10 g) of Body TSL	Condition	
SAR measured	250 mW input power	1.58 mW / g
SAR normalized	normalized to 1W	6.32 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	6.19 mW / g ± 16.5 % (k=2)

² Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

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Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	53.7 Ω -3.7 j Ω
Return Loss	- 25.9dB

Antenna Parameters with Body TSL

Impedance, transformed to feed point	49.4 Ω - 5.1 j Ω
Return Loss	-25.6dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.387 ns
----------------------------------	----------

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	April 22, 2004

DASY5 Validation Report for Head TSL

Certificate No: D835V2-4d020_Jul09

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Date/Time: 2009-7-15 14:54:13

Test Laboratory: TMC, Beijing, China

DUT: Dipole 835 MHz; Type: D835V2; Serial: SN: 4d020

Communication System: CW Frequency: 835 MHz Duty Cycle: 1:1

Medium: Head 835MHz

Medium parameters used: $f = 835$ MHz; $\sigma = 0.91$ mho/m; $\epsilon_r = 41.2$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

DASY5 Configuration:

- Probe: ES3DV3 - SN3149; ConvF(6.34, 6.34, 6.34); Calibrated: 08.12.08
- Electronics: DAE4 Sn771; Calibration: 21.11.08
- Phantom: 2mm Oval Phantom ELI4; Type: QDOVA001BB
- Measurement SW: DASY5, V5.0 Build 119.9; Postprocessing SW: SEMCAD, V13.2 Build 87

Pin=250mW; d=15mm/Zoom Scan (7x7x7)/Cube 0:

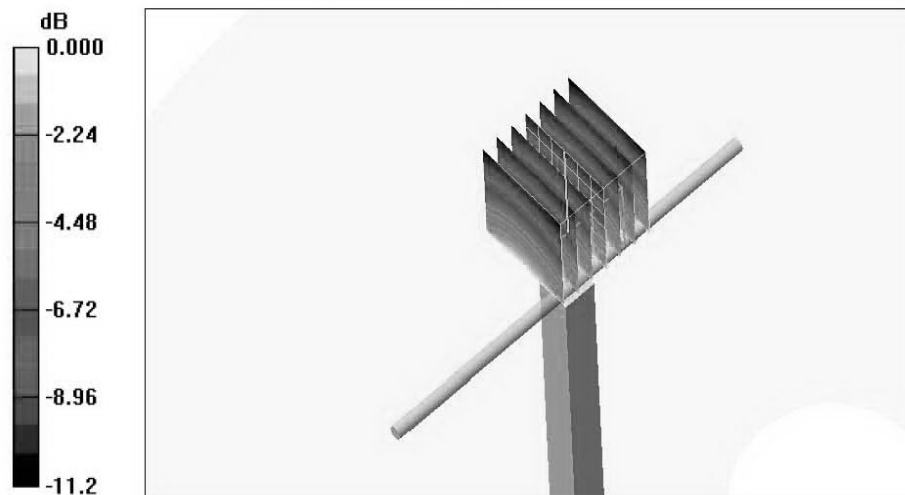
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 55.2 V/m; Power Drift = -0.019 dB

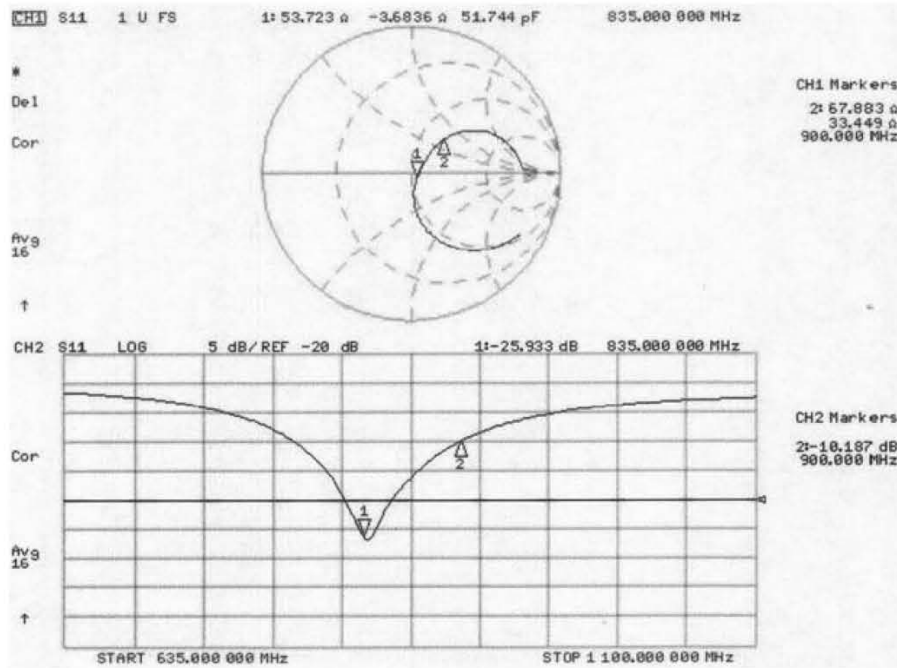
Peak SAR (extrapolated) = 3.16 W/kg

SAR(1 g) = 2.4 mW/g; SAR(10 g) = 1.55 mW/g

Maximum value of SAR (measured) = 2.74 mW/g



Impedance Measurement Plot for Head TSL



DASY5 Validation Report for Body TSL

Date/Time: 2009-7-15 11:27:23

Test Laboratory: TMC, Beijing, China

DUT: Dipole 835 MHz; Type: D835V2; Serial: SN: 4d020

Communication System: CW Frequency: 835 MHz Duty Cycle: 1:1

Medium: Body 835MHz

Medium parameters used: $f = 835 \text{ MHz}$; $\sigma = 0.99 \text{ mho/m}$; $\epsilon_r = 54.6$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

DASY5 Configuration:

- Probe: ES3DV3 - SN3149; ConvF(6.02, 6.02, 6.02); Calibrated: 08.12.08
- Electronics: DAE4 Sn771; Calibration: 21.11.08
- Phantom: 2mm Oval Phantom ELI4; Type: QDOVA001BB
- Measurement SW: DASY5, V5.0 Build 119.9; Postprocessing SW: SEMCAD, V13.2 Build 87

Pin=250mW; d=15mm/Zoom Scan (7x7x7)/Cube 0:

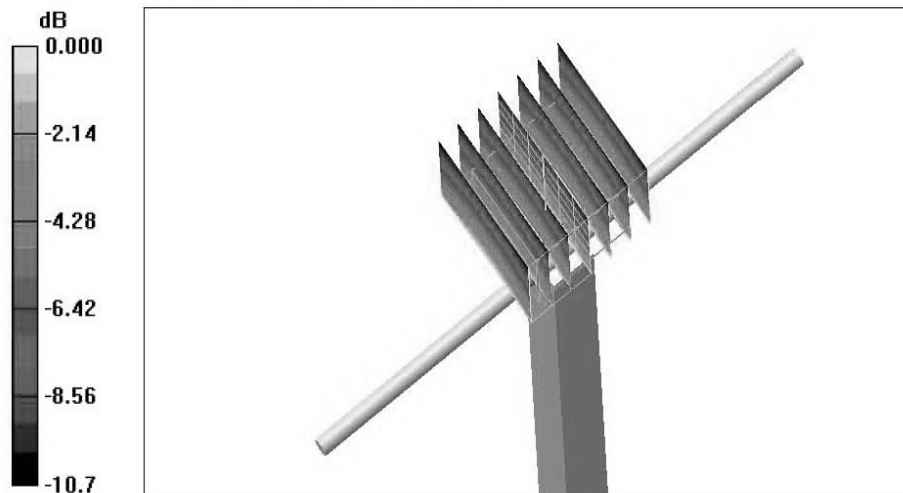
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 54.1 V/m; Power Drift = -0.004 dB

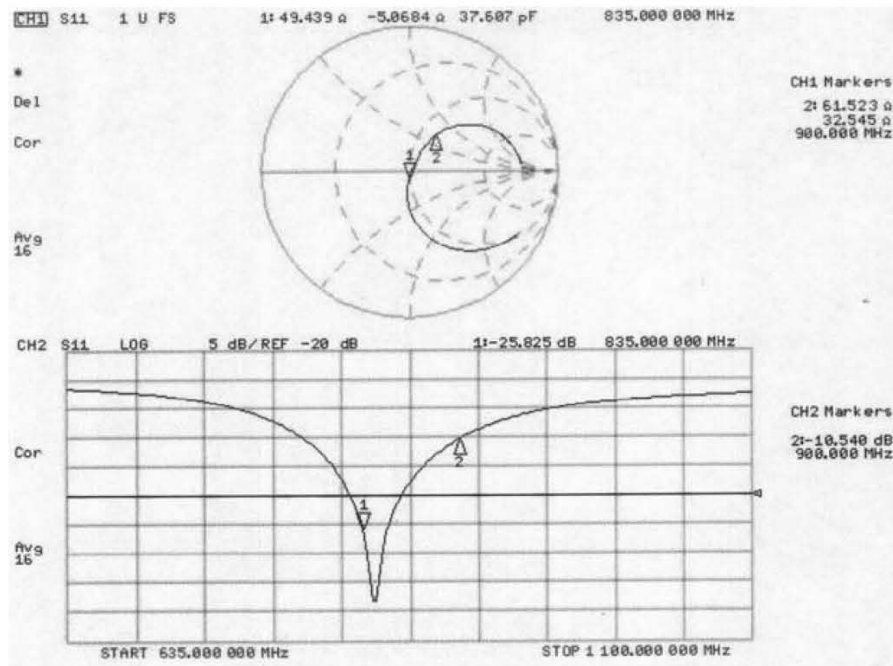
Peak SAR (extrapolated) = 3.81 W/kg

SAR(1 g) = 2.41 mW/g; SAR(10 g) = 1.58 mW/g

Maximum value of SAR (measured) = 2.71 mW/g



Impedance Measurement Plot for Body TSL



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ANNEX F: D1900V2 Dipole Calibration Certificate

信息产业部通信计量中心
Telecommunication Metrology Center of MII



Client

TA

Certificate No: D1900V2-5d060_Jul09

CALIBRATION CERTIFICATE

Object	D1900V2 - SN: 5d060
Calibration Procedure(s)	TMC-XZ-01-027 Calibration procedure for dipole validation kits
Calibration date:	July 15, 2009
Condition of the calibrated item	In Tolerance

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Primary Standards	ID #	Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
Power Meter NRVD	101253	19-Jun-09 (TMC, No. JZ09-248)	Jun-10
Power sensor NRV-Z5	100333	19-Jun-09 (TMC, No. JZ09-248)	Jun-10
Reference Probe ES3DV3	SN 3149	08-Dec-08(SPEAG, No.ES3-3149_Dec08)	Dec-09
DAE4	SN 771	21-Nov-08(SPEAG, No.DAE4-771_Nov08)	Nov-09
RF generator E4438C	MY45092879	18-Jun-09(TMC, No.JZ09-302)	Jun-10
Network Analyzer 8753E	US38433212	03-Aug-08(TMC, No.JZ08-056)	Aug-09

	Name	Function	Signature
Calibrated by:	Lin Hao	SAR Test Engineer	
Reviewed by:	Qi Dianyuan	SAR Project Leader	
Approved by:	Lu Bingsong	Deputy Director of the laboratory	

Issued: July 15, 2009

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